

**66164**

SINGLE CHANNEL OPTOCOUPLER



09/22/03

**Features:**

- High Reliability
- Base lead eliminated for improved noise immunity
- Rugged package
- Stability over wide temperature
- +500V electrical isolation

**Applications:**

- Eliminate ground loops
- Level shifting
- Line receiver
- Switching power supplies
- Motor control

**DESCRIPTION**

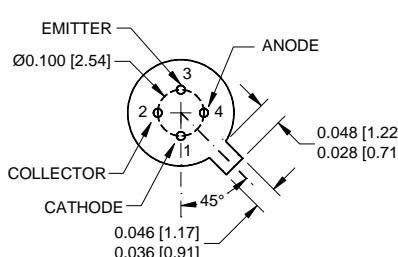
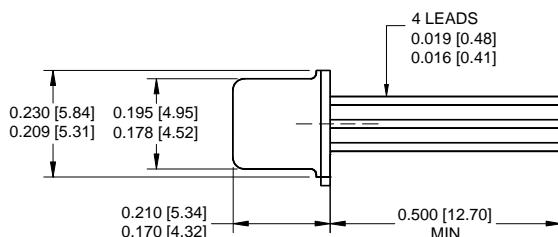
The **66164** contains a gallium arsenide infrared 940nm LED optically coupled to a silicon planar phototransistor. The optocoupler is built on a TO-46 header. The internal base connection has been eliminated for improved noise immunity.

**ABSOLUTE MAXIMUM RATINGS**

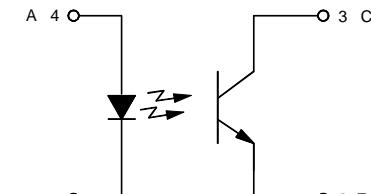
Input to Output Isolation Voltage (Note 3) .....	500V
Emitter-Collector Voltage .....	5V
Collector-Emitter Voltage .....	50V
Reverse Input Voltage .....	7V
Input Diode Continuous Forward Current (Note 1) .....	50mA
Peak Forward Input Current (value applies for $t_w \leq 1\mu s$ , PRR < 300 pps) .....	500mA
Continuous Collector Current .....	50mA
Continuous Transistor Power Dissipation (Note 2) .....	300mW
Storage Temperature .....	-65°C to +150°C
Operating Free-Air Temperature Range.....	-55°C to +125°C
Lead Solder Temperature (10 seconds, 1/16" from case) .....	240°C

**Notes:**

1. Derate linearly to 125°C free-air temperature at the rate of 0.5 mA/°C above 25°C.
2. Derate linearly to 125°C free-air temperature at the rate of 3 mW/°C above 25°C.
3. Measured with input diode leads shorted together and output leads shorted together.

**Package Dimensions**

ALL DIMENSIONS ARE IN INCHES [MILLIMETERS]

**Schematic Diagram**

ANODE ELECTRICALLY CONNECTED TO CASE.

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**ELECTRICAL CHARACTERISTICS** $T_A = 25^\circ\text{C}$  unless otherwise specified.

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS
Input Diode Static Reverse Current	$I_R$			1	$\mu\text{A}$	$V_R = 3\text{V}$
Input Diode Static Forward Voltage	$V_F$		1.15	1.2	V	$I_F = 2\text{mA}$
Input Diode Static Forward Voltage	$V_F$		1.3	1.5	V	$I_F = 50\text{mA}$
Reverse Breakdown Voltage	$B_{VR}$	7	12		V	$I_R = 100\mu\text{A}$
Input Diode Capacitance	$C_{IN}$		25		pF	$V = 0\text{V}, f = 1\text{MHz}$

**OUTPUT TRANSISTOR** $T_A = 25^\circ\text{C}$  unless otherwise specified.

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	50			V	$I_C = 1\text{mA}, I_B = 0, I_F = 0$
Emitter-Collector Breakdown Voltage	$V_{(BR)ECO}$	7			V	$I_C = 10\mu\text{A}, I_E = 10\mu\text{A}, I_F = 0$
Collector-Emitter Dark Current	$I_{CEO1}$			50	nA	$V_{CE} = 50\text{V}, I_F = 0\text{mA}$
	$I_{CEO2}$			10	nA	$V_{CE} = 5\text{V}, I_F = 0\text{mA}$

**COUPLED CHARACTERISTICS** $T_A = 25^\circ\text{C}$  unless otherwise specified.

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS
On State Collector Current	$I_C(\text{ON})$	4			mA	$V_{CE} = 5\text{V}, I_F = 10\text{mA}$
On State Collector Current	$I_C(\text{ON})$	4		10	mA	$V_{CE} = 0.4\text{V}, I_F = 10\text{mA}$
On State Collector Current $-55^\circ\text{C}$	$I_C(\text{ON})$	4			mA	$V_{CE} = 5\text{V}, I_F = 10\text{mA}$
Collector-Emitter Saturation Voltage	$V_{CE(\text{SAT})}$			0.4	V	$I_F = 50\text{mA}, I_C = 10\text{mA}$
Isolation Resistance	$R_{ISO}$	$10^9$			$\Omega$	$V_{\text{IN-OUT}} = 500\text{V}$
Input to Output Capacitance	$C_{IO}$		2	2.5	pF	$f = 1\text{MHz}$
Delay Time	$t_d$		2	4	$\mu\text{s}$	$V_{CE} = 5\text{V}, I_F = 2\text{mA}, R_L = 100\Omega$
Storage Time	$t_s$		0.2	0.5	$\mu\text{s}$	$V_{CE} = 5\text{V}, I_F = 2\text{mA}, R_L = 100\Omega$
Rise Time	$t_r$		3	5	$\mu\text{s}$	$V_{CE} = 5\text{V}, I_F = 2\text{mA}, R_L = 100\Omega$
Fall Time	$t_f$		4	5	$\mu\text{s}$	$V_{CE} = 5\text{V}, I_F = 2\text{mA}, R_L = 100\Omega$

**RECOMMENDED OPERATING CONDITIONS:**

PARAMETER	SYMBOL	MIN	MAX	UNITS
Input Current, Low Level	$I_{FL}$	0	1	$\mu\text{A}$
Input Current, High Level	$I_{FH}$	2	10	mA
Supply Voltage	$V_{CE}$	5	50	V
Operating Temperature	$T_A$	-55	125	$^\circ\text{C}$

**SELECTION GUIDE**

PART NUMBER	PART DESCRIPTION
66164-001	Commercial
66164-101	Screened